

## UTC UNISONIC TECHNOLOGIES CO., LTD

4N65-S **Power MOSFET** 

### 4A, 650V N-CHANNEL **POWER MOSFET**

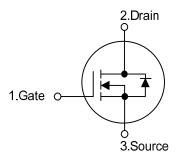
#### **DESCRIPTION**

The UTC 4N65-S is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristic. This power MOSFET is usually used in high speed switching applications including power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

#### **FEATURES**

- \*  $R_{DS(ON)}$  < 2.9 $\Omega$  @  $V_{GS}$  = 10V,  $I_{D}$  = 2A
- \* Fast Switching Capability
- \* Avalanche Energy Specified
- \* Improved dv/dt Capability, High Ruggedness

#### **SYMBOL**

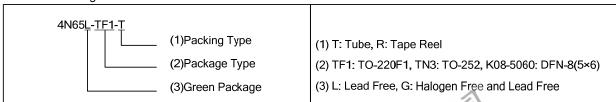


# TO-220F1 TO-252 DFN-8(5x6)

#### ORDERING INFORMATION

Ordering Number		Dooksons	Pin Assignment							Doolsing		
Lead Free	Halogen Free	Package	1	2	3	4	5	6	7	8	Packing	
4N65L-TF1-T	4N65G-TF1-T	TO-220F1	G	D	S	1	ı	-	-	-	Tube	
4N65L-TN3-T	4N65G-TN3-T	TO-252	G	О	S	ı	ı	•	-	-	Tape Reel	
-	4N65G-K08-5060-R	DFN-8(5×6)	S	S	S	G	D	D	D	D	Tape Reel	

Pin Assignment: G: Gate D: Drain S: Source Note:



#### **MARKING**



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#### ■ **ABSOLUTE MAXIMUM RATINGS** (T<sub>C</sub> = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{DSS}$	650	V
Gate-Source Voltage		$V_{GSS}$	±30	V
Drain Current	Continuous	$I_{D}$	4.0	Α
	Pulsed (Note2)	I <sub>DM</sub>	16	Α
Avalanche Energy	Single Pulsed (Note3)	E <sub>AS</sub>	150	mJ
Peak Diode Recovery dv/dt (Note4)		dv/dt	4.5	V/ns
Power Dissipation	TO-220F1		36	W
	TO-252	$P_{D}$	50	W
	DFN-8(5×6)		30	W
Junction Temperature		$T_J$	+150	°C
Operating Temperature		T <sub>OPR</sub>	-55 ~ +150	°C
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C

- Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

  Absolute maximum ratings are stress ratings only and functional device operation is not implied.
  - 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
  - 3. L = 18.75mH,  $I_{AS}$  = 4A,  $V_{DD}$  = 50V,  $R_G$  = 25  $\Omega$ , Starting  $T_J$  = 25°C
  - 4.  $I_{SD} \le 4A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25$ °C

#### **■ THERMAL DATA**

PARAMETER	PACKAGE	SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220F1		62.5	°C/W
	TO-252	$\theta_{JA}$	110	°C/W
	DFN-8(5×6)		75 (Note)	°C/W
Junction to Case	TO-220F1		3.47	°C/W
	TO-252	$\theta_{JC}$	2.5	°C/W
	DFN-8(5×6)		4.17 (Note)	°C/W

Note: Note: The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.



#### **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> =25°C, unless otherwise specified)

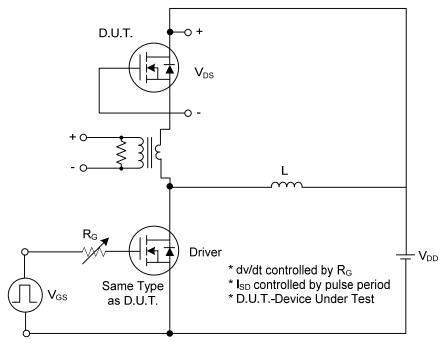
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS									
Drain-Source Breakdown Voltage		$BV_{DSS}$	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	650			V		
Drain-Source Leakage Current		I <sub>DSS</sub>	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$			10	μΑ		
Gate-Source Leakage Current	Forward		$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA		
	Reverse	I <sub>GSS</sub>	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA		
Breakdown Voltage Temperature C	Coefficient	$\triangle BV_{DSS}/\triangle T_{J}$	I <sub>D</sub> =250μA, Referenced to 25°C		0.6		V/°C		
ON CHARACTERISTICS									
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V		
Static Drain-Source On-State Re	sistance	R <sub>DS(ON)</sub>	$V_{GS} = 10 \text{ V}, I_D = 2A$			2.9	Ω		
DYNAMIC CHARACTERISTICS									
Input Capacitance		C <sub>ISS</sub>	V <sub>DS</sub> = 25 V. V <sub>GS</sub> = 0V.		420	550	pF		
Output Capacitance		Coss	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{MHz}$		40	60	pF		
Reverse Transfer Capacitance		$C_{RSS}$	71 = 1MH2		4	8	pF		
SWITCHING CHARACTERISTIC	CS10								
Turn-On Delay Time		$t_{D(ON)}$			60		ns		
Turn-On Rise Time		$t_R$	$V_{DS} = 30 \text{ V}, I_{D} = 0.5 \text{ A},$		25		ns		
Turn-Off Delay Time		$t_{D(OFF)}$	$R_G = 25\Omega \text{ (Note 1, 2)}$		125		ns		
Turn-Off Fall Time		t <sub>F</sub>			30		ns		
Total Gate Charge		$Q_G$	V <sub>DS</sub> = 50 V,I <sub>D</sub> = 1.3 A,		15	20	nC		
Gate-Source Charge		$Q_GS$	V <sub>GS</sub> = 10V (Note 1, 2)		5		nC		
Gate-Drain Charge		$Q_GD$	VGS - 10V (Note 1, 2)		2		nC		
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS									
Drain-Source Diode Forward Voltage		$V_{SD}$	$V_{GS} = 0 \text{ V}, I_{S} = 4A$			1.4	V		
Maximum Continuous Drain-Source		Is				4	Α		
Diode Forward Current		'S				7	^		
Maximum Pulsed Drain-Source Diode		I <sub>SM</sub>				16	Α		
Forward Current		ISIVI				10	/ \		

Note: 1. Pulse Test: Pulse width≤300µs, Duty cycle≤2%.

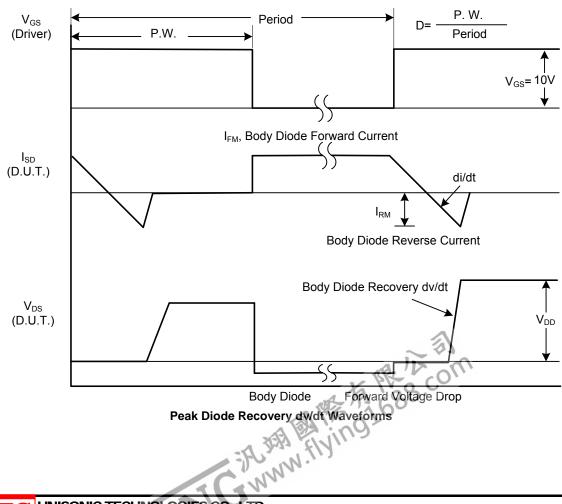


<sup>2.</sup> Essentially independent of operating temperature.

#### **TEST CIRCUITS AND WAVEFORMS**

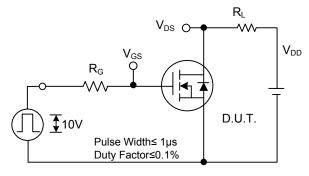


Peak Diode Recovery dv/dt Test Circuit

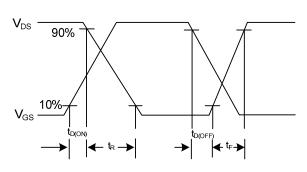


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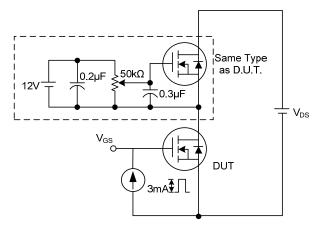
#### **■ TEST CIRCUITS AND WAVEFORMS (Cont.)**



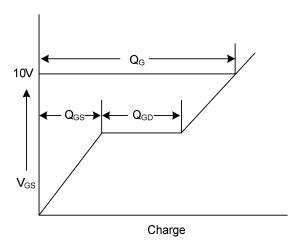
**Switching Test Circuit** 



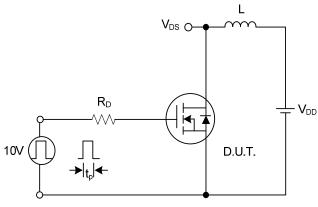
**Switching Waveforms** 



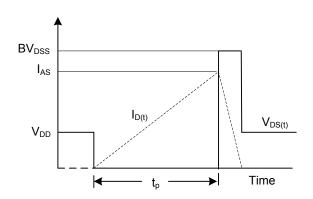
**Gate Charge Test Circuit** 



**Gate Charge Waveform** 



**Unclamped Inductive Switching Test Circuit** 



**Unclamped Inductive Switching Waveforms** 

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